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Jameco Part Number 50235TI

**SN5432, SN54LS32, SN54S32,
SN7432, SN74LS32, SN74S32**
QUADRUPLE 2-INPUT POSITIVE-OR GATES

DECEMBER 1983 - REVISED MARCH 1988

- Package Options Include Plastic "Small Outline" Packages, Ceramic Chip Carriers and Flat Packages, and Plastic and Ceramic DIPs
- Dependable Texas Instruments Quality and Reliability

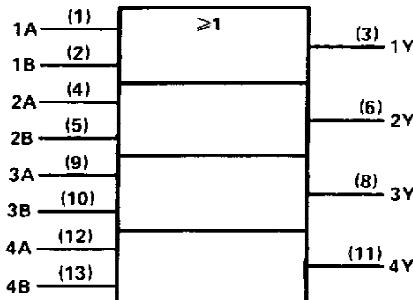
description

These devices contain four independent 2-input OR gates.

The SN5432, SN54LS32 and SN54S32 are characterized for operation over the full military range of -55°C to 125°C . The SN7432, SN74LS32 and SN74S32 are characterized for operation from 0°C to 70°C .

FUNCTION TABLE (each gate)

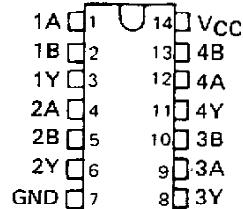
INPUTS		OUTPUT
A	B	Y
H	X	H
X	H	H
L	L	L

logic symbol†

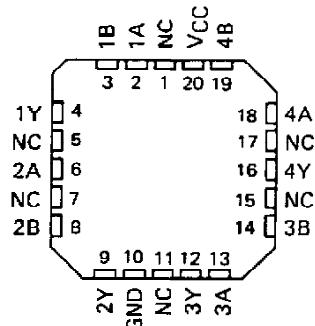
† This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12. Pin numbers shown are for D, J, N, or W packages.

SN5432, SN54LS32, SN54S32 . . . J OR W PACKAGE
SN7432 . . . N PACKAGE
SN74LS32, SN74S32 . . . D OR N PACKAGE

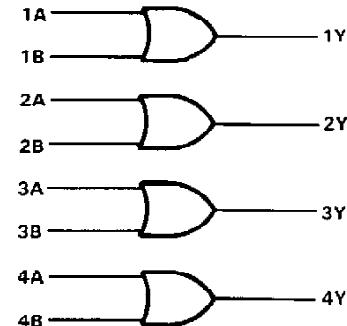
(TOP VIEW)



SN54LS32, SN54S32 . . . FK PACKAGE
(TOP VIEW)



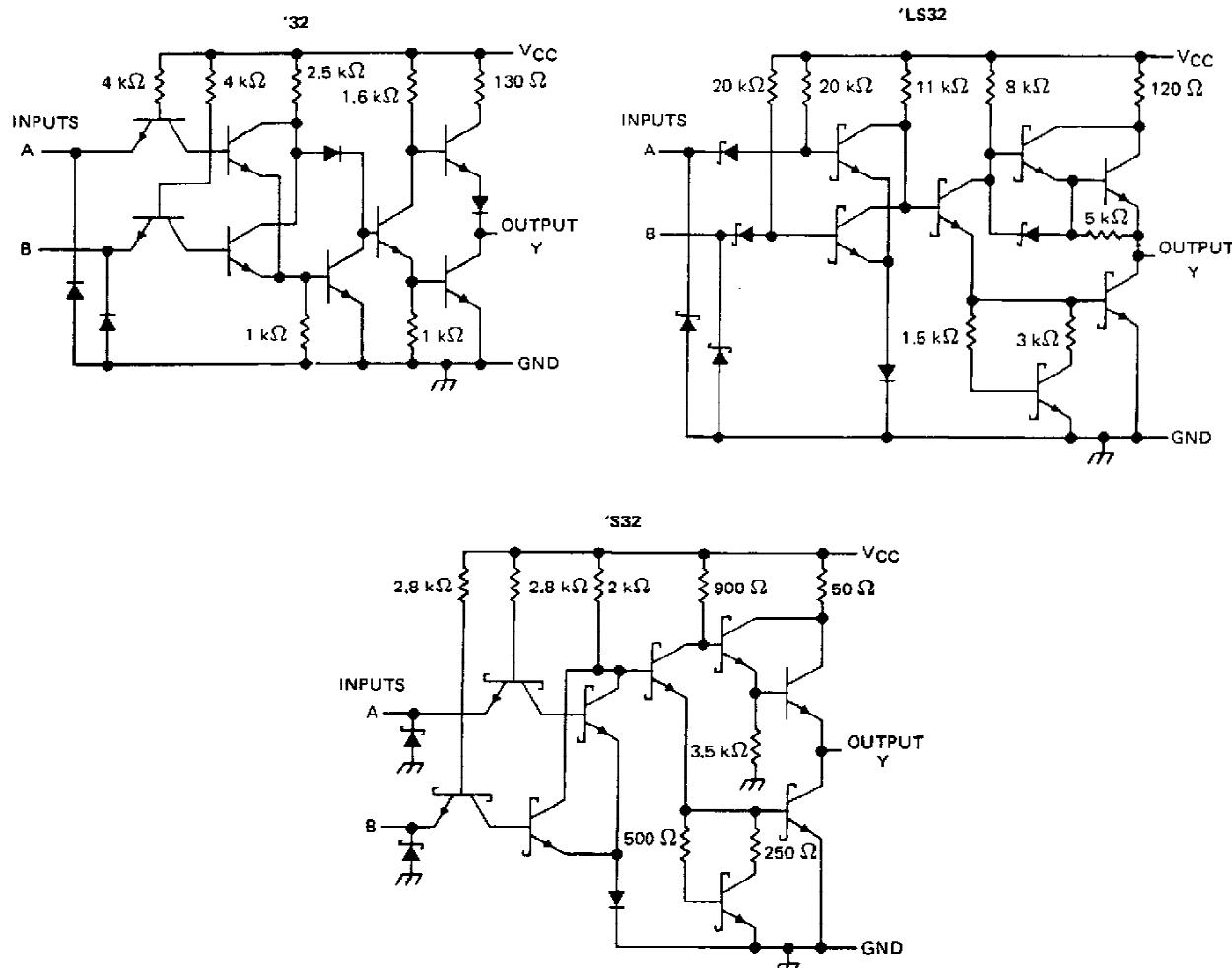
NC - No internal connection

logic diagram**positive logic**

$$Y = A + B \text{ or } Y = \overline{\overline{A} \cdot \overline{B}}$$

**SN5432, SN54LS32, SN54S32,
SN7432, SN74LS32, SN74S32
QUADRUPLE 2-INPUT POSITIVE-OR GATES**

schematics (each gate)



Resistor values shown are nominal

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, V_{CC} (see Note 1)	7 V
Input voltage: '32, 'S32	5.5 V
'LS32	7 V
Operating free-air temperature: SN54'	-55°C to 125°C
SN74'	0°C to 70°C
Storage temperature range	-65°C to 150°C

NOTE 1: Voltage values are with respect to network ground terminal.

SN5432, SN7432
QUADRUPLE 2-INPUT POSITIVE-OR GATES

recommended operating conditions

	SN5432			SN7432			UNIT
	MIN	NOM	MAX	MIN	NOM	MAX	
V _{CC} Supply voltage	4.5	5	5.5	4.75	5	5.25	V
V _{IH} High-level input voltage	2			2			V
V _{IL} Low-level input voltage			0.8			0.8	V
I _{OH} High-level output current			-0.8			-0.8	mA
I _{OL} Low-level output current			16			16	mA
T _A Operating free-air temperature	-55		125	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS [†]	SN5432			SN7432			UNIT
		MIN	TYP [‡]	MAX	MIN	TYP [‡]	MAX	
V _{IK}	V _{CC} = MIN, I _I = -12 mA			-1.5			-1.5	V
V _{QH}	V _{CC} = MIN, V _{IH} = 2 V, I _{OH} = -0.8 mA	2.4	3.4		2.4	3.4		V
V _{QL}	V _{CC} = MIN, V _{IL} = 0.8 V, I _{OL} = 16 mA		0.2	0.4	0.2	0.4		V
I _I	V _{CC} = MAX, V _I = 5.5 V			1			1	mA
I _{IH}	V _{CC} = MAX, V _I = 2.4 V			40			40	μA
I _{IL}	V _{CC} = MAX, V _I = 0.4 V			1.6			-1.6	mA
I _{OS\$}	V _{CC} = MAX	-20	-55		-18	-55		mA
I _{CCH}	V _{CC} = MAX, See Note 2		15	22	15	22		mA
I _{CCL}	V _{CC} = MAX, V _I = 0 V	23	38		23	38		mA

[†] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

[‡] All typical values are at V_{CC} = 5 V, T_A = 25°C.

\$ Not more than one output should be shorted at a time.

NOTE 2: One input at 4.5 V, all others at GND.

switching characteristics, V_{CC} = 5 V, T_A = 25°C (see note 3)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	MIN	TYP	MAX	UNIT
t _{PLH}	A or B	Y	R _L = 400 Ω, C _L = 15 pF	10	15		ns
t _{PHL}				14	22		ns

NOTE 3: Load circuits and voltage waveforms are shown in Section 1.

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SN54LS32, SN74LS32 QUADRUPLE 2-INPUT POSITIVE-OR GATES

recommended operating conditions

	SN54LS32			SN74LS32			UNIT
	MIN	NOM	MAX	MIN	NOM	MAX	
V _{CC} Supply voltage	4.5	5	5.5	4.75	5	5.25	V
V _{IH} High-level input voltage	2			2			V
V _{IL} Low-level input voltage			0.7			0.8	V
I _{OH} High-level output current			-0.4			-0.4	mA
I _{OL} Low-level output current			4			8	mA
T _A Operating free-air temperature	-55		125	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS [†]	SN54LS32			SN74LS32			UNIT
		MIN	TYP [‡]	MAX	MIN	TYP [‡]	MAX	
V _{IK}	V _{CC} = MIN, I _I = -18 mA			-1.5			-1.5	V
V _{OH}	V _{CC} = MIN, V _{IH} = 2 V, I _{OH} = -0.4 mA	2.5	3.4		2.7	3.4		V
V _{OL}	V _{CC} = MIN, V _{IL} = MAX, I _{OL} = 4 mA	0.25	0.4		0.25	0.4		V
	V _{CC} = MIN, V _{IL} = MAX, I _{OL} = 8 mA				0.35	0.5		
I _I	V _{CC} = MAX, V _I = 7 V			0.1			0.1	mA
I _{IH}	V _{CC} = MAX, V _I = 2.7 V			20			20	μA
I _{IL}	V _{CC} = MAX, V _I = 0.4 V			-0.4			-0.4	mA
I _{OS\$}	V _{CC} = MAX	-20		-100	-20		-100	mA
I _{CCH}	V _{CC} = MAX, See Note 2	3.1	6.2		3.1	6.2		mA
I _{CCL}	V _{CC} = MAX, V _I = 0 V	4.9	9.8		4.9	9.8		mA

[†] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

[‡] All typical values are at V_{CC} = 5 V, T_A = 25°C.

\$ Not more than one output should be shorted at a time and the duration of the short-circuit should not exceed one second.

NOTE 2: One input at 4.5 V, all others at GND.

switching characteristics, V_{CC} = 5 V, T_A = 25°C (see note 3)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	MIN	TYP	MAX	UNIT
t _{PLH} t _{PHL}	A or B	Y	R _L = 2 kΩ, C _L = 15 pF	14	22		ns
				14	22		ns

NOTE 3: Load circuits and voltage waveforms are shown in Section 1.

SN54S32, SN74S32
QUADRUPLE 2-INPUT POSITIVE-OR GATES

recommended operating conditions

	SN54S32			SN74S32			UNIT
	MIN	NOM	MAX	MIN	NOM	MAX	
V_{CC} Supply voltage	4.5	5	5.5	4.75	5	5.25	V
V_{IH} High-level input voltage	2			2			V
V_{IL} Low-level input voltage				0.8		0.8	V
I_{OH} High-level output current				-1		-1	mA
I_{OL} Low-level output current				20		20	mA
T_A Operating free-air temperature	-55	125	0	0	70	70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS [†]	SN54S32			SN74S32			UNIT	
		MIN	TYP [‡]	MAX	MIN	TYP [‡]	MAX		
V_{IK}	$V_{CC} = \text{MIN}$, $I_I = -18 \text{ mA}$				-1.2		-1.2	V	
V_{OH}	$V_{CC} = \text{MIN}$, $V_{IH} = 2 \text{ V}$, $I_{OH} = -1 \text{ mA}$	2.5	3.4		2.7	3.4		V	
V_{OL}	$V_{CC} = \text{MIN}$, $V_{IL} = 0.8 \text{ V}$, $I_{OL} = 20 \text{ mA}$				0.5		0.5	V	
I_I	$V_{CC} = \text{MAX}$, $V_I = 5.5 \text{ V}$				1		1	mA	
I_{IH}	$V_{CC} = \text{MAX}$, $V_I = 2.7 \text{ V}$				50		50	μA	
I_{IL}	$V_{CC} = \text{MAX}$, $V_I = 0.5 \text{ V}$				-2		-2	mA	
$I_{OS\$}$	$V_{CC} = \text{MAX}$	-40	-100	-40	-40	-100	-100	mA	
I_{CCH}	$V_{CC} = \text{MAX}$, See Note 2				18	32	18	32	mA
I_{CCL}	$V_{CC} = \text{MAX}$, $V_I = 0 \text{ V}$				38	68	38	68	mA

[†] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

[‡] All typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^\circ\text{C}$.

§ Not more than one output should be shorted at a time and the duration of the short-circuit should not exceed one second.

NOTE 2: One input at 4.5 V, all others at GND.

switching characteristics, $V_{CC} = 5 \text{ V}$, $T_A = 25^\circ\text{C}$ (see note 3)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	MIN	TYP	MAX	UNIT
t_{PLH}	A or B	Y	$R_L = 280 \Omega$, $C_L = 15 \text{ pF}$	4	7	ns	
				4	7	ns	
t_{PHL}	A or B	Y	$R_L = 280 \Omega$, $C_L = 50 \text{ pF}$	5		ns	
				5		ns	

NOTE 3: Load circuits and voltage waveforms are shown in Section 1.

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